


<b>Search Notes</b>  	<b>Application/Control No.</b>  10001389	<b>Applicant(s)/Patent Under Reexamination</b>  WIKE ET AL.
	<b>Examiner</b>  Le, Uyen-Chau N	<b>Art Unit</b>  2876

SEARCHED			
Class	Subclass	Date	Examiner
SEARCH UPDATED		12/26/06	UCL

SEARCH NOTES		
Search Notes	Date	Examiner
STIC SEARCH (TRACKING # 192620)	06/19/06	UCL
TEXT SEARCH ONLY -- SEE SEARCH HISTORY PRINTOUT	12/26/06	UCL

INTERFERENCE SEARCH			
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